Search Notes

Application/Control No.	Applicant(s)/Patent ι Reexamination	ınder
10/519,829	KARCH ET AL.	
Examiner	Art Unit	
TAN Q. NGUYEN	3661	

SEARCHED				
Class	Subclass	Date	Examiner	
701	67,29,35	1/28/2008	TN	
702	182			
73	162,118.2			
74	335			
340	438,453			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PLUS SEARCH	10/17/2007	TN	
EAST SEARCH	2/11/2008	TN	